

General Description

The SLG59M1657V is a high performance 8.4 m Ω , 4 A single-channel nFET integrated power switch which can operate with a 2.5 V to 5.5 V V_{DD} supply to switch power rails from as low as 0.9 V up to the supply voltage. The SLG59M1657V incorporates two-level overload current protection, thermal shutdown protection, and inrush current control which can easily be adjusted by a small external capacitor.

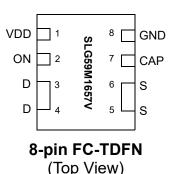
Using a proprietary MOSFET design, the SLG59M1657V achieves a stable 8.4 m Ω RDS_{ON} across a wide input voltage range. In addition, the SLG59M1657V's package also exhibits low thermal resistance for high-current operation using Dialog's proprietary CuFET technology.

Fully specified over the -40 $^{\circ}$ C to 125 $^{\circ}$ C temperature range, the SLG59M1657V is packaged in a space-efficient, low thermal resistance, RoHS-compliant 1.5 mm x 2.0 mm STDFN package.

Features

- 1.5 x 2.0 mm TDFN package (2 fused pins for drain and 2 fused pins for source)
- Logic level ON pin capable of supporting 0.85 V CMOS Logic
- · User selectable ramp rate with external capacitor
- 8.4 m Ω RDS_{ON} while supporting 4 A
- · Two Over Current Protection Modes
 - Short Circuit Current Limit
 - Active Current Limit
- · Over Temperature Protection
- · Pb-Free / Halogen-Free / RoHS compliant
- Operating Temperature: -40 °C to 125°C
- · Operating Voltage: 2.5 V to 5.5 V

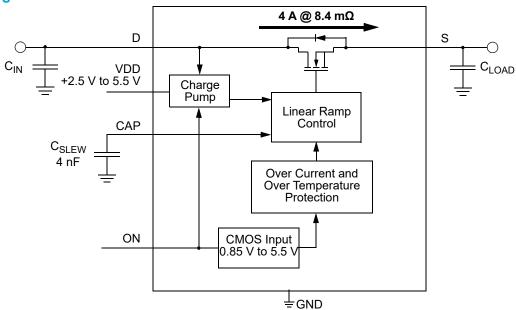
Pin Configuration



Applications

- · Notebook Power Rail Switching
- Tablet Power Rail Switching
- Smartphone Power Rail Switching

Block Diagram





Pin Description

Pin#	Pin Name	Type	Pin Description
1	VDD	PWR	With an internal 1.8 V $V_{DD(UVLO)}$, VDD supplies the power for the operation of the power switch and internal control circuitry. Bypass the VDD pin to GND with a 0.1 μ F (or larger) capacitor.
2	ON	Input	A low-to-high transition on this pin initiates the operation of the SLG59M1657V's state machine. ON is a CMOS input with ON_V _{IL} < 0.3 V and ON_V _{IH} > 0.85 V thresholds. While there is an internal pull-down circuit to GND (~4 M Ω), connect this pin directly to a general-purpose output (GPO) of a microcontroller, an application processor, or a system controller.
3, 4	D	MOSFET	Drain terminal connection of the n-channel MOSFET (2 pins fused for D). Connect at least a low-ESR 0.1 μ F capacitor from this pin to ground. Capacitors used at D should be rated at 10 V or higher.
5, 6	S	MOSFET	Source terminal connection of the n-channel MOSFET (2 pins fused for S). Connect a low-ESR capacitor from this pin to ground and consult the Electrical Characteristics table for recommended C _{LOAD} range. Capacitors used at S should be rated at 10 V or higher.
7	CAP	Input	A low-ESR, stable dielectric, ceramic surface-mount capacitor connected from CAP pin to GND sets the V_S slew rate and overall turn-on time of the SLG59M1657V. For best performance C_{SLEW} value should be \geq 1.5 nF and voltage level should be rated at 10 V or higher.
8	GND	GND	Ground connection. Connect this pin to system analog or power ground plane.

Ordering Information

Part Number	Туре	Production Flow
SLG59M1657V	FC-TDFN 8L	Extended Industrial, -40 °C to 125 °C
SLG59M1657VTR	FC-TDFN 8L (Tape and Reel)	Extended Industrial, -40 °C to 125 °C



Absolute Maximum Ratings

Parameter	Description	Conditions	Min.	Тур.	Max.	Unit
V _{DD}	Power Supply				7	V
V _D to GND	Power Switch Input Voltage to GND		-0.3	-	7	V
V _S to GND	Power Switch Output Voltage to GND		-0.3	-	V_D	V
ON and CAP to GND	ON and CAP Pin Voltages to GND		-0.3		7	V
T _O	Operating Temperature		-40	-	125	ŷ
T _S	Storage Temperature		-65	1	150	°C
T _A	Rated Operating Temperature		-40	-	125	°C
ESD _{HBM}	ESD Protection	Human Body Model	2000	-	-	V
ESD _{CDM}	ESD Protection	Charged Device Model		-	-	V
MSL	Moisture Sensitivity Level			,		
$\theta_{\sf JA}$	Thermal Resistance	1.5 x 2 mm, 8L TDFN; Determined using 1 in ² , 1 oz. copper pads under each D and S terminals and FR4 pcb material		69		°C/W
W _{DIS}	Package Power Dissipation			-	1	W
MOSFET IDS _{CONT}	Max Continuous Switch Current		-		4	Α
MOSFET IDS _{PK}	Peak Current from Drain to Source	For no more than 1 ms with 1% duty cycle			4.5	Α

Note: Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Electrical Characteristics

T_A = -40 to 125 °C (unless otherwise stated)

Parameter	Description	Conditions	Min.	Тур.	Max.	Unit
V _{DD}	Power Supply Voltage	-40 to 125°C	2.5		5.5	V
V _{DD(UVLO)}	V _{DD} Undervoltage Lockout Threshold	$V_{DD}\uparrow$		1.8		V
		when OFF; $T_A = 70 ^{\circ}\text{C}$; $V_S = 0 ^{\circ}\text{V}$; $V_D = V_{DD} = 5.5 ^{\circ}\text{V}$			1	μA
I _{DD}	Power Supply Current	when OFF; $T_A = 85 ^{\circ}\text{C}$; $V_S = 0 \text{V}$; $V_D = V_{DD} = 5.5 \text{V}$			1	μA
		when OFF; $T_A = 125 ^{\circ}\text{C}$; $V_S = 0 \text{V}$; $V_D = V_{DD} = 5.5 \text{V}$			1.5	μA
		when ON, no Load		70	120	μA
		T _A = 25 °C; I _{DS} = 100 mA		8.4	10	mΩ
RDS _{ON}	ON Resistance	T _A = 85 °C; I _{DS} = 100 mA		10	12	mΩ
		T _A =125 °C; I _{DS} = 100 mA		12	14.4	mΩ
V _D	Drain Voltage		0.9		V_{DD}	V
MOSFET IDS	Current from D to S	Continuous			4	Α



Electrical Characteristics (continued)

 T_A = -40 to 125 °C (unless otherwise stated)

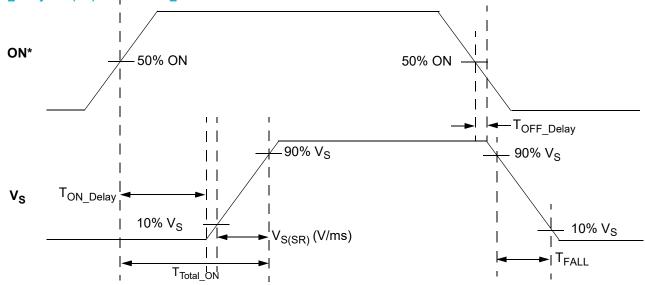
Parameter	Description	Conditions	Min.	Тур.	Max.	Unit
		V _D = V _{DD} = 5.5 V; V _S = 0 V; ON = 0 V; T _A = 70 °C			1	μA
I _{FET_OFF}	MOSFET OFF Leakage Current	V _D = V _{DD} = 5.5 V; V _S = 0 V; ON = 0 V; T _A = 85 °C			1	μA
		V _D = V _{DD} = 5.5 V; V _S = 0 V; ON = 0 V; T _A = 125 °C			20	μA
		10% V _S to 90% V _S	Set by	External (SLEW ¹	ms
$V_{S(SR)}$	Slew Rate	Example: C_{SLEW} = 4 nF, V_{DD} = V_{D} = 5 V, C_{LOAD} = 10 μ F, R_{LOAD} = 20 Ω		3		V/ms
T _{ON_Delay}	ON Delay Time	50% ON to V _S Ramp Start		200		μs
T _{OFF_Delay}	OFF Delay Time	50% ON to V_S Fall Start, $V_{DD} = V_D = 5 V$, no C_{LOAD} , $R_{LOAD} = 20 \Omega$		22		μs
T _{FALL}	V _S Fall Time	90% V_S to 10% V_S , $V_{DD} = V_D = 5 V$, no C_{LOAD} , $R_{LOAD} = 20 Ω$		10		μs
C _{LOAD}	Output Capacitive Load to GND	C _{LOAD} connected from S to GND			500	μF
ON_V _{IH}	High Input Voltage on ON pin		0.85		V_{DD}	V
ON_V _{IL}	Low Input Voltage on ON pin		-0.3	0	0.25	V
1	Active Current Limit, I _{ACL}	MOSFET will automatically limit current when V _S > 250 mV		6.0		Α
I _{LIMIT}	Short Circuit Current Limit, I _{SCL}	MOSFET will automatically limit current when V _S < 250 mV		0.5		Α
THERMON	Thermal shutoff turn-on temperature			150		°C
THERMOFF	Thermal shutoff turn-off temperature			130		°C
THERM _{TIME}	Thermal shutoff time				1	ms

Notes:

^{1.} Refer to typical timing parameter vs. C_{SLEW} performance charts for additional information when available.



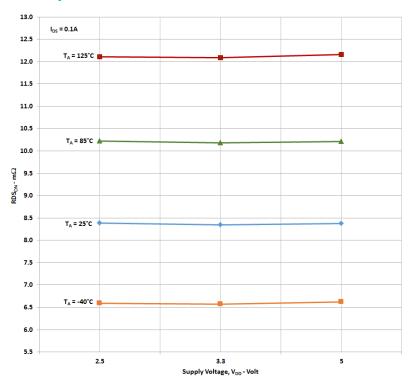




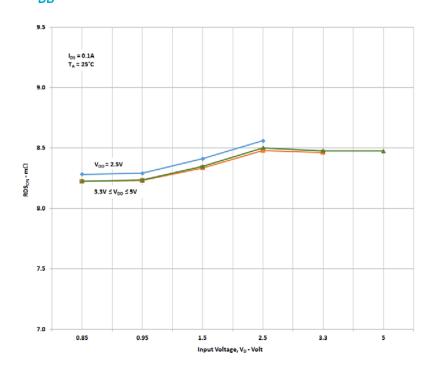


Typical Performance Characteristics

$\ensuremath{\mathsf{RDS}_\mathsf{ON}}$ vs. $\ensuremath{\mathsf{V}_\mathsf{DD}},$ and Temperature

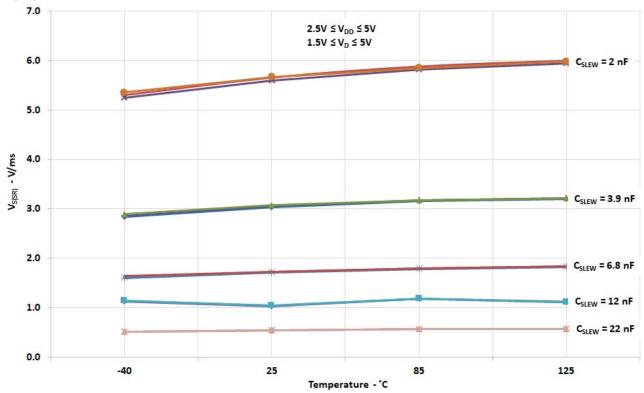


RDS_{ON} vs. V_D and V_{DD}

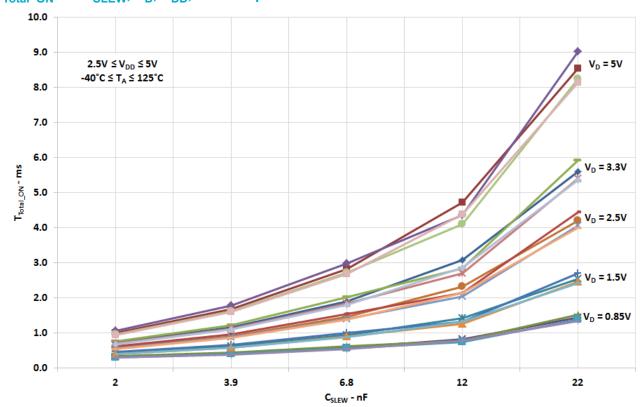




 $V_{S(SR)}$ vs. Temperature, V_D , V_{DD} , and C_{SLEW}



 $T_{Total\ ON}$ vs. C_{SLEW} , V_D , V_{DD} , and Temperature



Datasheet Revision 1.01 15-Apr-2019



Typical Operation Waveforms



Figure 1. Typical Turn ON operation waveform for V_{DD} = V_{D} = 5 V, C_{SLEW} = 4 nF, C_{LOAD} = 10 μ F, R_{LOAD} = 20 Ω



Figure 2. Typical Turn ON operation waveform for V_{DD} = V_{D} = 5 V, C_{SLEW} = 12 nF, C_{LOAD} = 10 μ F, R_{LOAD} = 20 Ω





Figure 3. Typical Turn OFF operation waveform for V_{DD} = V_D = 5 V, C_{SLEW} = 4 nF, no C_{LOAD} , R_{LOAD} = 20 Ω



Figure 4. Typical Turn OFF operation waveform for V_{DD} = V_D = 5 V, C_{SLEW} = 4 nF, C_{LOAD} = 10 μ F, R_{LOAD} = 20 Ω

SLG59M1657V



An Ultra-small 3 mm², 8.4 m Ω , 4 A, 125 °C-Rated Internally-protected Integrated Power Switch

SLG59M1657V Power-Up/Power-Down Sequence Considerations

To ensure glitch-free power-up under all conditions, apply V_{DD} first, followed by V_{D} after V_{DD} exceeds 1 V. Then allow V_{D} to reach 90% of its max value before toggling the ON pin from Low-to-High. Likewise, power-down in reverse order.

If V_{DD} and V_{D} need to be powered up simultaneously, glitching can be minimized by having a suitable load capacitor. A 10 μ F C_{LOAD} will prevent glitches for rise times of V_{DD} and V_{D} less than 2 ms.

If the ON pin is toggled HIGH before V_{DD} and V_{D} have reached their steady-state values, the IPS timing parameters may differ from datasheet specifications.

The slew rate of output V_S follows a linear ramp set by a capacitor connected to the CAP pin. A larger capacitor value at the CAP pin produces a slower ramp, reducing inrush current from capacitive loads.

SLG59M1657V Current Limiting Operation

The SLG59M1657V has two types of current limiting triggered by the output S pin voltage.

1. Standard Current Limiting Mode (with Thermal Shutdown Protection)

When the V_S voltage > 250 mV, the output current is initially limited to the Active Current Limit (I_{ACL}) specification listed in the Electrical Characteristics table. The ACL monitor's response time is very fast and is triggered within a few microseconds to sudden (transient) changes in load current. When a load current overload is detected, the ACL monitor increases the FET resistance to keep the current from exceeding the power switch's I_{ACL} threshold.

However, if a load-current overload condition persists where the die temperature rises because of the increased FET resistance, the power switch's internal Thermal Shutdown Protection circuit can be activated. If the die temperature exceeds the listed THERM_{ON} specification, the FET is shut OFF completely, thereby allowing the die to cool. When the die cools to the listed THERM_{OFF} temperature threshold, the FET is allowed to turn back on. This process may repeat as long as the output current overload condition persists.

2. Short Circuit Current Limiting Mode (with Thermal Shutdown Protection)

When the V_S voltage < 250 mV (which is the case with a hard short, such as a solder bridge on the power rail), the power switch's internal Short-circuit Current Limit (SCL) monitor limits the FET current to approximately 500 mA (the I_{SCL} threshold). While the internal Shutdown Protection circuit remains enabled and since the I_{SCL} threshold is much lower than the I_{ACL} threshold, thermal shutdown protection may become activated only at higher ambient temperatures.



Power Dissipation

The junction temperature of the SLG59M1657V depends on different factors such as board layout, ambient temperature, and other environmental factors. The primary contributor to the increase in the junction temperature of the SLG59M1657V is the power dissipation of its power MOSFET. Its power dissipation and the junction temperature in nominal operating mode can be calculated using the following equations:

$$PD = RDS_{ON} \times I_{DS}^{2}$$

where:

PD = Power dissipation, in Watts (W) RDS_{ON} = Power MOSFET ON resistance, in Ohms (Ω) I_{DS} = Output current, in Amps (A)

and

$$T_J = PD \times \theta_{JA} + T_A$$

where:

 T_J = Junction temperature, in Celsius degrees (°C) θ_{JA} = Package thermal resistance, in Celsius degrees per Watt (°C/W) T_A = Ambient temperature, in Celsius degrees (°C)

During active current-limit operation, the SLG59M1657V's power dissipation can be calculated by taking into account the voltage drop across the power switch $(V_D - V_S)$ and the magnitude of the output current in active current-limit operation (I_{ACL}) :

$$PD = (V_D - V_S) \times I_{ACL} \text{ or}$$

$$PD = (V_D - (R_{LOAD} \times I_{ACL})) \times I_{ACL}$$

where:

PD = Power dissipation, in Watts (W) V_D = Input Voltage, in Volts (V) R_{LOAD} = Load Resistance, in Ohms (Ω) I_{ACL} = Output limited current, in Amps (A) V_S = R_{LOAD} x I_{ACL}

For more information on Dialog GreenFET3 integrated power switch features, please visit our <u>Documents</u> search page at our website and see <u>App Note "AN-1068 GreenFET3 Integrated Power Switch Basics"</u>.



Layout Guidelines:

- 1.The VDD pin needs a 0.1 μF and 10 μF external capacitors to smooth pulses from the power supply. Locate these capacitors as close as possible to the SLG59M1657V's PIN1.
- 2.Since the D and S pins dissipate most of the heat generated during high-load current operation, it is highly recommended to make power traces as short, direct, and wide as possible. A good practice is to make power traces with an absolute minimum widths of 15 mils (0.381 mm) per Ampere. A representative layout, shown in Figure 5, illustrates proper techniques for heat to transfer as efficiently as possible out of the device;
- 3.To minimize the effects of parasitic trace inductance on normal operation, it is recommended to connect input C_{IN} and output C_{LOAD} low-ESR capacitors as close as possible to the SLG59M1657V's D and S pins;
- 4. The GND pin should be connected to system analog or power ground plane.
- 5. 2 oz. copper is recommended for high current operation.

SLG59M1657V Evaluation Board:

A GFET3 Evaluation Board for SLG59M1657V is designed according to the statements above and is illustrated on Figure 5. Please note that evaluation board has D_Sense and S_Sense pads. They cannot carry high currents and dedicated only for RDS_{ON} evaluation.

Please solder your SLG59M1657V here

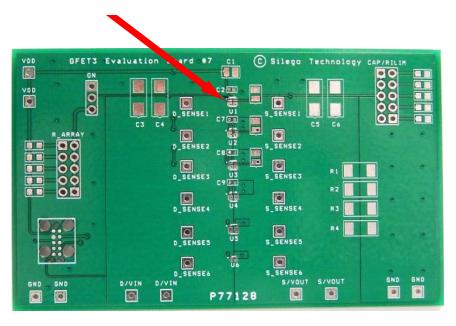


Figure 5. SLG59M1657V Evaluation Board



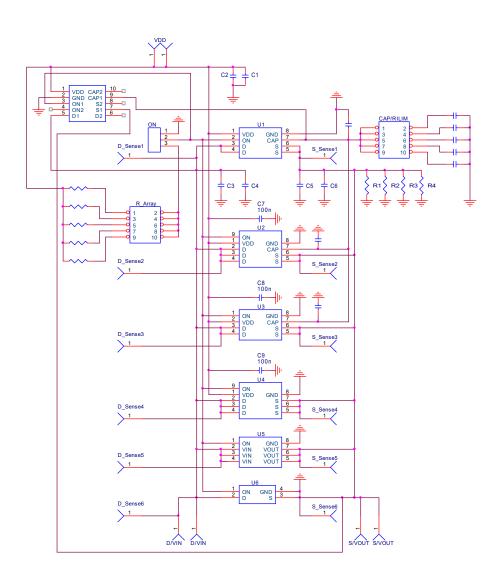


Figure 6. SLG59M1657V Evaluation Board Connection Circuit



Basic Test Setup and Connections

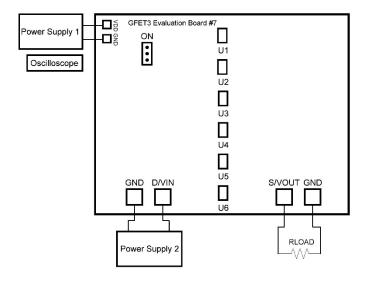


Figure 7. Typical connections for GFET3 Evaluation

EVB Configuration

- 1. Connect oscilloscope probes to D/VIN, S/VOUT, ON, etc.;
- 2.Turn on Power Supply 1 and set desired V_{DD} from 2.5 V...5.5 V range;
- 3.Turn on Power Supply 2 and set desired V_D from 0.85 V...5.5 V range;
- 4.Toggle the ON signal High or Low to observe SLG59M1657V operation.



Package Top Marking System Definition

	XXA	Part Code + Assembly Site
Date Code + Revision	DDR	
Pin 1 Identifier	0	Lot Traceability

XX - Part Code Field¹
A - Assembly Site Code Field²
DD - Date Code Field¹
R - Part Revision Code Field²

LL - Lot Traceability Field¹

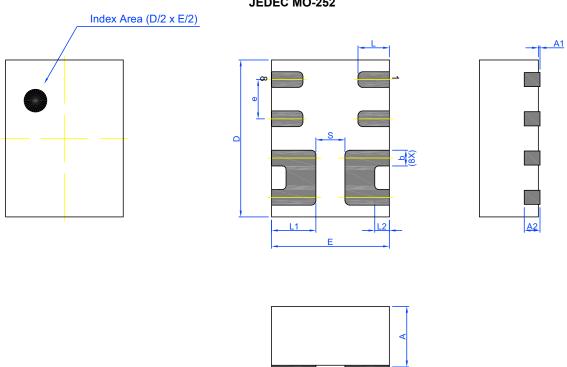
Note 1: Each character in code field can be alphanumeric A-Z and 0-9

Note 2: Character in code field can be alphabetic A-Z



Package Drawing and Dimensions

8 Lead TDFN Package 1.5 x 2.0 mm (Fused Lead) JEDEC MO-252



Unit: mm

Symbol	Min	Nom.	Max	Symbol	Min	Nom.	Max
Α	0.70	0.75	0.80	L	0.35	0.40	0.45
A1	0.005	-	0.060	L1	0.515	0.565	0.615
A2	0.15	0.20	0.25	L2	0.135	0.185	0.235
b	0.15	0.20	0.25	е	(0.50 BSC	
D	1.95	2.00	2.05	S	0.37 REF		
Е	1.45	1.50	1.55				

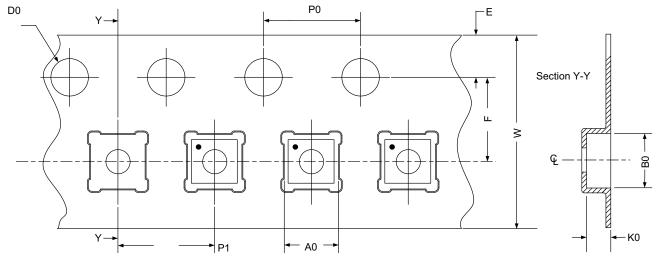


Tape and Reel Specifications

Pac	ckago	# of	Nominal Max Units		Reel &	Leader (min)		Trailer (min)		Tape	Part	
	ckage ype	Pins	Package Size [mm]	per Reel	per Box	Hub Size [mm]	Pockets	Length [mm]	Pockets	Length [mm]	Width [mm]	Pitch [mm]
	FN 8L Green	8	1.5 x 2.0 x 0.75	3000	3000	178 / 60	100	400	100	400	8	4

Carrier Tape Drawing and Dimensions

Package Type	Pocket BTM Length	Pocket BTM Width	Pocket Depth	Index Hole Pitch	Pocket Pitch	Index Hole Diameter	Index Hole to Tape Edge	Index Hole to Pocket Cen- ter	Tape Width
	A0	В0	K0	P0	P1	D0	E	F	W
TDFN 8L FC Green	1.68	2.18	0.9	4	4	1.5	1.75	3.5	8



Refer to EIA-481 specification

Recommended Reflow Soldering Profile

Please see IPC/JEDEC J-STD-020: latest revision for reflow profile based on package volume of 2.25 mm³ (nominal). More information can be found at www.jedec.org.

SLG59M1657V



An Ultra-small 3 mm², 8.4 mΩ, 4 A, 125 °C-Rated Internally-protected Integrated Power Switch

Revision History

Date	Version	Change
4/15/2017	1.01	Updated Style and Formatting Updated Charts Added Layout Guidelines Fixed typos
2/23/2017	1.00	Production Release

Mouser Electronics

Authorized Distributor

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Dialog Semiconductor: SLG59M1657V